

General Description

The WSD2068 is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WSD2068 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

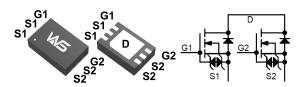
Product Summery

BV _{DSS}	R _{DSON}	I _D		
20V	15.5mΩ	7.5A		

Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.
- DC-DC Power System
- ESD:2KV

DFN2X3A_EP Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
V_{DS}	Drain-Source Voltage	20	V	
V_{GS}	Gate-Source Voltage	±12	V	
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	7.5	А	
I _D @T _A =70℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	6.5	А	
I _{DM}	Pulsed Drain Current ²	30	А	
P _D @T _A =25°C	Total Power Dissipation ³	1.5	W	
P _D @T _A =70°C	Total Power Dissipation ³	1.0	W	
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$	
TJ	Operating Junction Temperature Range	-55 to 150	$^{\circ}$	

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹ (Steady State)		120	°C/W
R _{θJA}	Thermal Resistance Junction-ambient ¹ (t<10S)		83	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.022		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =5.5A		12	15.5	mΩ
R _{DS(ON)}		V _{GS} =2.5V , I _D =5.5A		16	20	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	0.3	0.7	1.0	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-2.32		mV/℃
I _{DSS}	Drain-Source Leakage Current	V _{DS} =16V , V _{GS} =0V , T _J =25°C			1	
		V _{DS} =16V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm12V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =10A		20		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		11		Ω
Q_g	Total Gate Charge (4.5V)			15	20	
Q_gs	Gate-Source Charge	V_{DS} =10V , V_{GS} =4.5V , I_{D} =5A		2.2		nC
Q_gd	Gate-Drain Charge			4.2		
T _{d(on)}	Turn-On Delay Time			148		
T _r	Rise Time	V_{DS} =10V , V_{GS} =10V , R_{G} =6 Ω ,		277		
T _{d(off)}	Turn-Off Delay Time	$I_D=5A$,RL=2 Ω		1616		ns
T _f	Fall Time			751		
C _{iss}	Input Capacitance			1219	1350	
Coss	Output Capacitance	V _{DS} =10V , V _{GS} =0V , f=1MHz		150		pF
C _{rss}	Reverse Transfer Capacitance			123		

Diode Characteristics

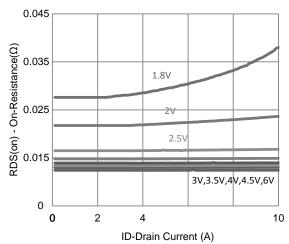
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,4}	V_G = V_D = $0V$, Force Current			5	Α
I _{SM}	Pulsed Source Current ^{2,4}				15	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃		0.76	1.3	V
t _{rr}	Reverse Recovery Time	lF=5A,dI/dt=100A/μs , Tյ=25℃		245		nS
Q_{rr}	Reverse Recovery Charge			1105		nC

Note:

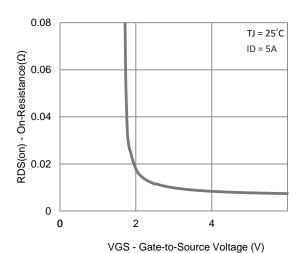
- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The power dissipation is limited by 150 ℃ junction temperature
- $\textbf{4.The data is theoretically the same as } \textbf{I}_{D} \text{ and } \textbf{I}_{DM} \text{ , in real applications , should be limited by total power dissipation.}$



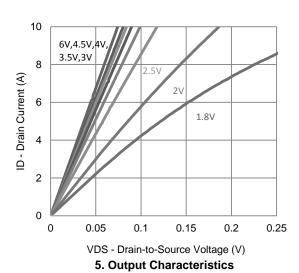
Typical Characteristics



1. On-Resistance vs. Drain Current



3. On-Resistance vs. Gate-to-Source Voltage



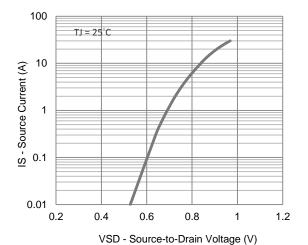
10 TJ = 25°C (V) TJ = 25°C 2

1

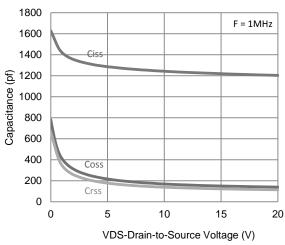
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VGS - Gate-to-Source Voltage (V)
2. Transfer Characteristics

2



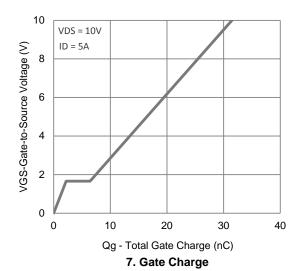
4. Drain-to-Source Forward Voltage

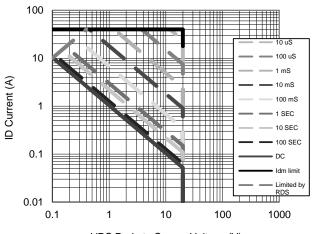


6. Capacitance

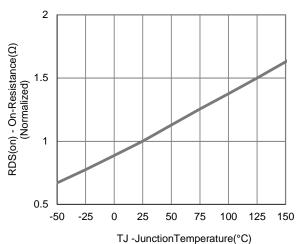


Typical Characteristics

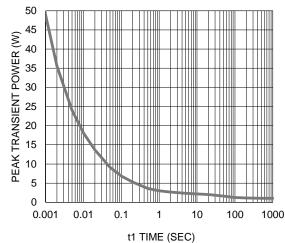




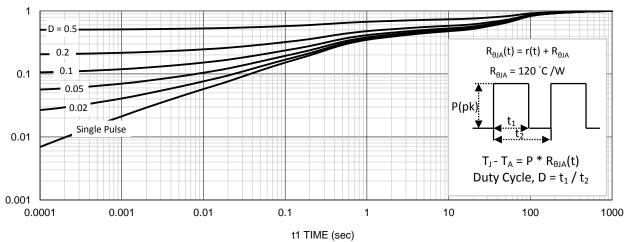




8. Normalized On-Resistance Vs Junction Temperature



10. Single Pulse Maximum Power Dissipation



11. Normalized Thermal Transient Junction to Ambient



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